

Maximum Ratings – Q1 and Q2 (@T_A = +25°C, unless otherwise specified.)

| Characteristic | | | Symbol | Q1 | Q2 | Units |
|---------------------------------------------------------|--------------|--------------------------------------------------|------------------|------------|--------------|-------|
| Drain-Source Voltage | | | V _{DSS} | 30 | -30 | V |
| Gate-Source Voltage | | | V _{GSS} | ±20 | ±20 | V |
| Continuous Drain Current (Note 6) V _{GS} = 10V | Steady State | T _A = +25°C T _A = +70°C | I _D | 6.5 5.2 | -6.2 -5.0 | A |
| | t<10s | T _A = +25°C T _A = +70°C | I _D | 8.2 6.7 | -8.0 -6.5 | A |
| Maximum Body Diode Forward Current (Note 6) | | | I _S | 2.2 | -2.5 | A |
| Pulsed Drain Current (10µs pulse, duty cycle = 1%) | | | I _{DM} | 40 | -40 | A |
| Avalanche Current (Notes 7) L = 0.1mH | | | I _{AS} | 14.5 | 22 | A |
| Avalanche Energy (Notes 7) L = 0.1mH | | | E _{AS} | 10.5 | 25 | mJ |

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | | Symbol | Value | Units |
|--------------------------------------------------|------------------------|-----------------------------------|-------------|-------|
| Total Power Dissipation (Note 5) | T _A = +25°C | P _D | 1.2 | W |
| | T _A = +70°C | | 0.8 | |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady state | R _{θJA} | 102 | °C/W |
| | t<10s | | 62 | |
| Total Power Dissipation (Note 6) | T _A = +25°C | P _D | 1.6 | W |
| | T _A = +70°C | | 1.0 | |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady state | R _{θJA} | 78 | °C/W |
| | t<10s | | 47 | |
| Thermal Resistance, Junction to Case (Note 6) | | R _{θJC} | 14.5 | |
| Operating and Storage Temperature Range | | T _J , T _{STG} | -55 to +150 | °C |

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|--------------------------------------------|---------------------|-----|------|------|------|-------------------------------------------------------------------------------------------|
| OFF CHARACTERISTICS (Note 8) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 30 | — | — | V | V _{GS} = 0V, I _D = 250µA |
| Zero Gate Voltage Drain Current | I _{DSS} | — | — | 1 | µA | V _{DS} = 24V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±100 | nA | V _{GS} = ±20V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 8) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | 1 | — | 3 | V | V _{DS} = V _{GS} , I _D = 250µA |
| Static Drain-Source On-Resistance | R _{DS(on)} | — | 19 | 25 | mΩ | V _{GS} = 10V, I _D = 6A |
| | | — | 22 | 29 | | V _{GS} = 4.5V, I _D = 5A |
| Diode Forward Voltage | V _{SD} | — | 0.7 | 1.2 | V | V _{GS} = 0V, I _S = 1.3A |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | |
| Input Capacitance | C _{iss} | — | 641 | — | pF | V _{DS} = 15V, V _{GS} = 0V f = 1.0MHz |
| Output Capacitance | C _{oss} | — | 66 | — | | |
| Reverse Transfer Capacitance | C _{rss} | — | 51 | — | | |
| Gate Resistance | R _G | — | 2.2 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz |
| Total Gate Charge (V _{GS} = 4.5V) | Q _g | — | 6 | — | nC | V _{DS} = 15V, I _D = 10A |
| Total Gate Charge (V _{GS} = 10V) | Q _g | — | 13.2 | — | | |
| Gate-Source Charge | Q _{gs} | — | 1.7 | — | | |
| Gate-Drain Charge | Q _{gd} | — | 2.2 | — | | |
| Turn-On Delay Time | t _{D(on)} | — | 3.3 | — | nS | V _{GS} = 10V, V _{DD} = 15V, R _G = 6Ω, I _D = 1A |
| Turn-On Rise Time | t _r | — | 4.4 | — | | |
| Turn-Off Delay Time | t _{D(off)} | — | 22.3 | — | | |
| Turn-Off Fall Time | t _f | — | 5.3 | — | | |

- Notes:
- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 - Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 - UIS in production with L = 0.1mH, starting T_A = +25°C.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to product testing.

Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|---------------------------------------------|---------------------|-----|------|------|------|------------------------------------------------------------------------------------------------|
| OFF CHARACTERISTICS (Note 8) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | -30 | — | — | V | V _{GS} = 0V, I _D = -250μA |
| Zero Gate Voltage Drain Current | I _{DSS} | — | — | -1 | μA | V _{DS} = -24V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±100 | nA | V _{GS} = ±20V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 8) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | -1 | — | -3 | V | V _{DS} = V _{GS} , I _D = -250μA |
| Static Drain-Source On-Resistance | R _{DS(ON)} | — | 21 | 28 | mΩ | V _{GS} = -10V, I _D = -6A |
| | | — | 29 | 38 | | V _{GS} = -4.5V, I _D = -5A |
| Diode Forward Voltage | V _{SD} | — | -0.7 | -1.2 | V | V _{GS} = 0V, I _S = -1.3A |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | |
| Input Capacitance | C _{iss} | — | 1241 | — | pF | V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz |
| Output Capacitance | C _{oss} | — | 146 | — | | |
| Reverse Transfer Capacitance | C _{rss} | — | 110 | — | | |
| Gate Resistance | R _G | — | 14.8 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz |
| Total Gate Charge (V _{GS} = -4.5V) | Q _g | — | 10.9 | — | nC | V _{DS} = -15V, I _D = -7A |
| Total Gate Charge (V _{GS} = -10V) | Q _g | — | 22 | — | | |
| Gate-Source Charge | Q _{gs} | — | 3.5 | — | | |
| Gate-Drain Charge | Q _{gd} | — | 4.7 | — | | |
| Turn-On Delay Time | t _{D(on)} | — | 9.7 | — | nS | V _{GS} = -10V, V _{DD} = -15V, R _{GEN} = 6Ω, I _D = -7A |
| Turn-On Rise Time | t _r | — | 17.1 | — | | |
| Turn-Off Delay Time | t _{D(off)} | — | 60.5 | — | | |
| Turn-Off Fall Time | t _f | — | 40.4 | — | | |

Notes: 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.

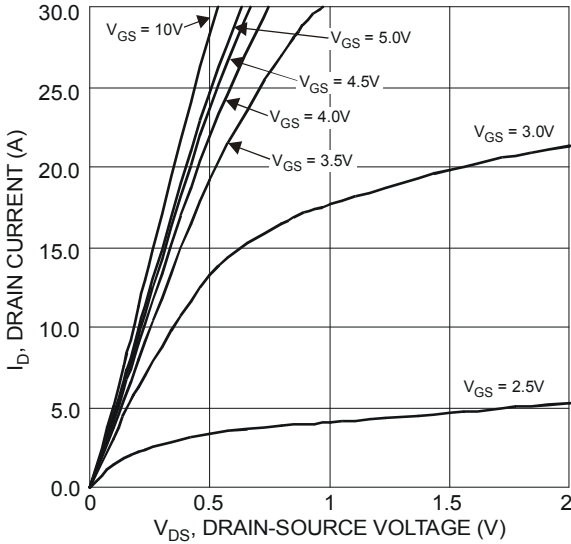


Figure 1 Typical Output Characteristics

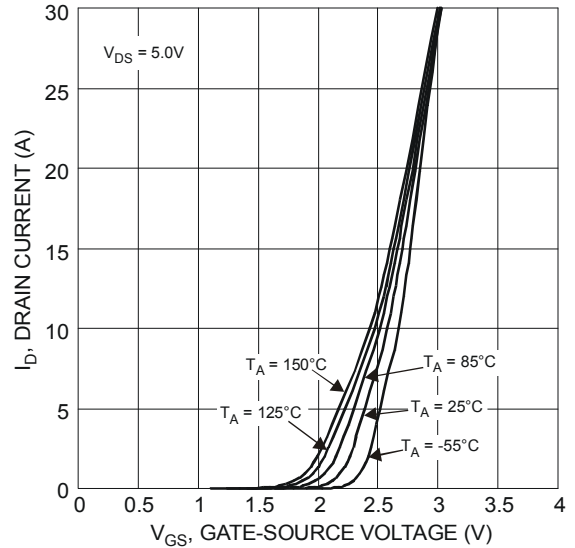


Figure 2 Typical Transfer Characteristics

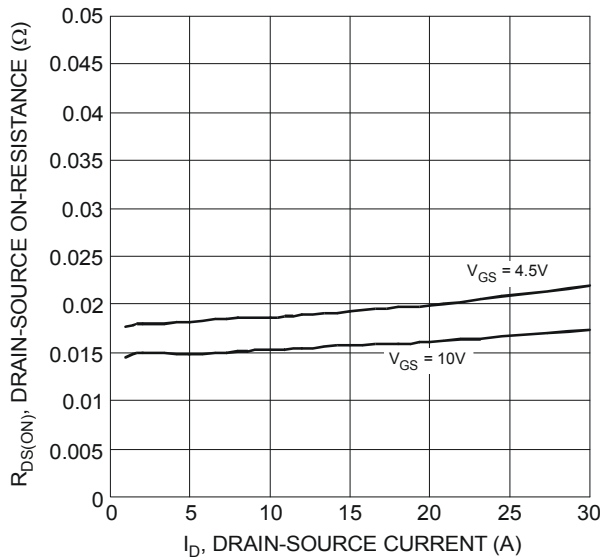


Figure 3 Typical On-Resistance vs. Drain Current and Gate Voltage

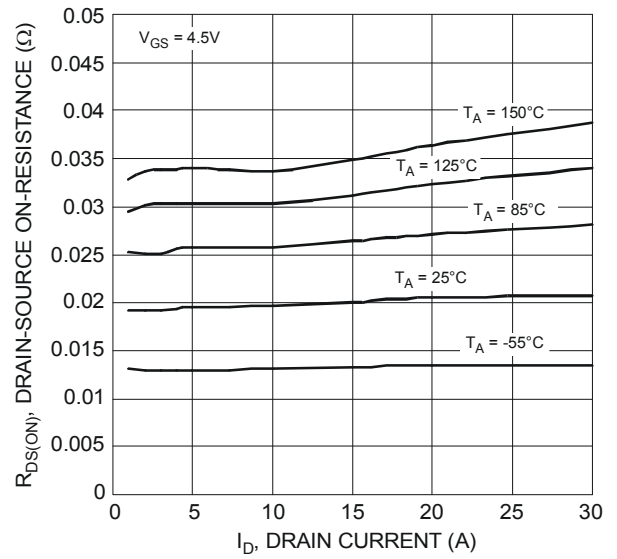


Figure 4 Typical On-Resistance vs. Drain Current and Temperature

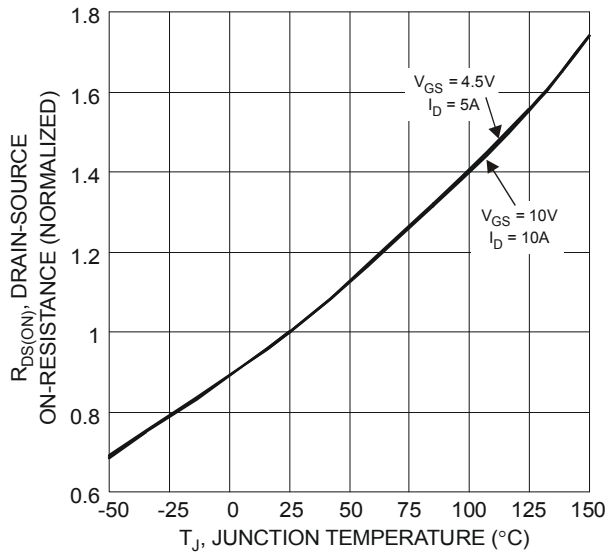


Figure 5 On-Resistance Variation with Temperature

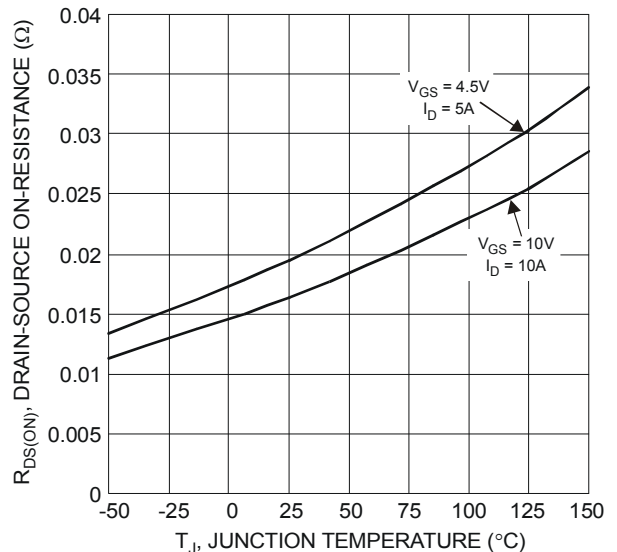


Figure 6 On-Resistance Variation with Temperature

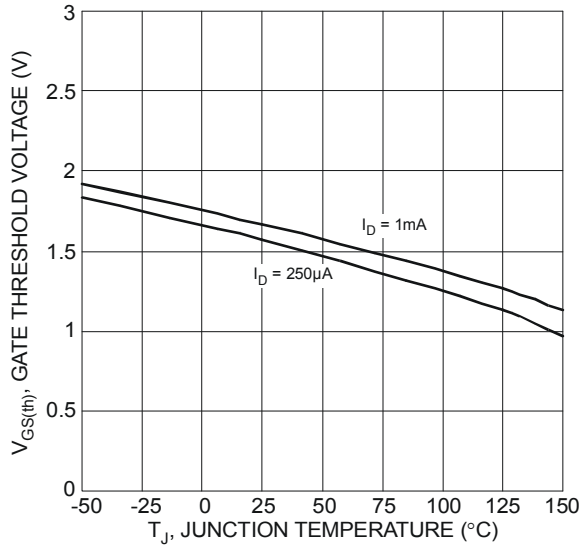


Figure 7 Gate Threshold Variation vs. Ambient Temperature

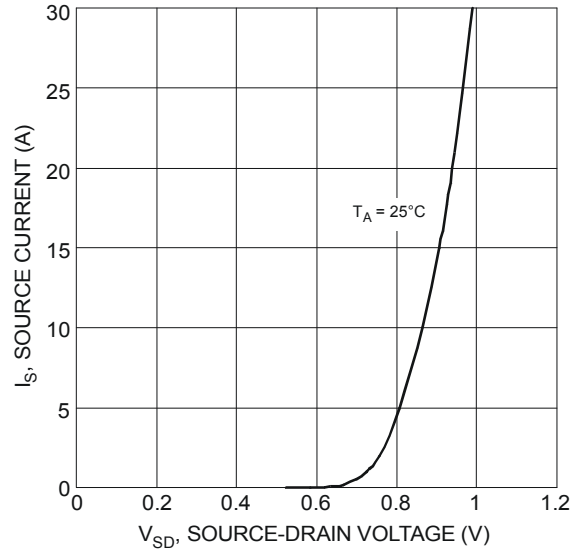


Figure 8 Diode Forward Voltage vs. Current

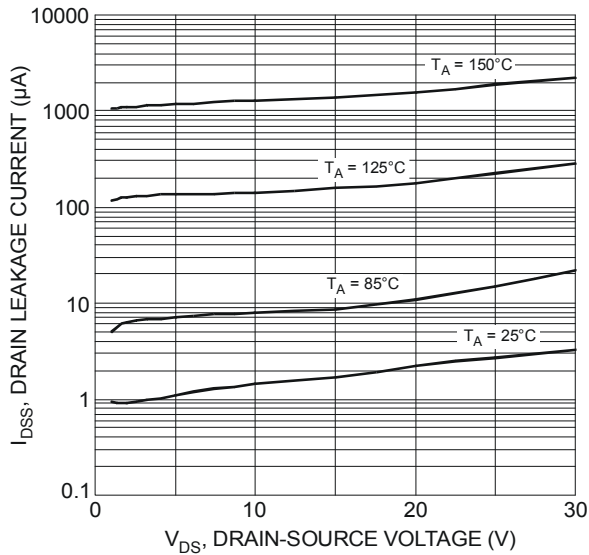


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

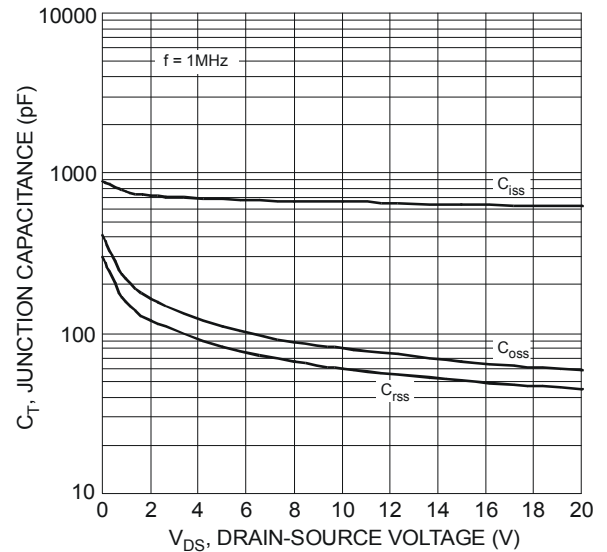


Figure 10 Typical Junction Capacitance

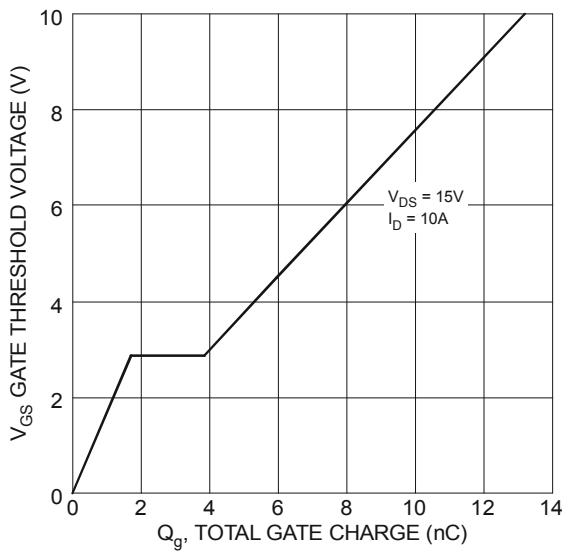


Figure 11 Gate Charge

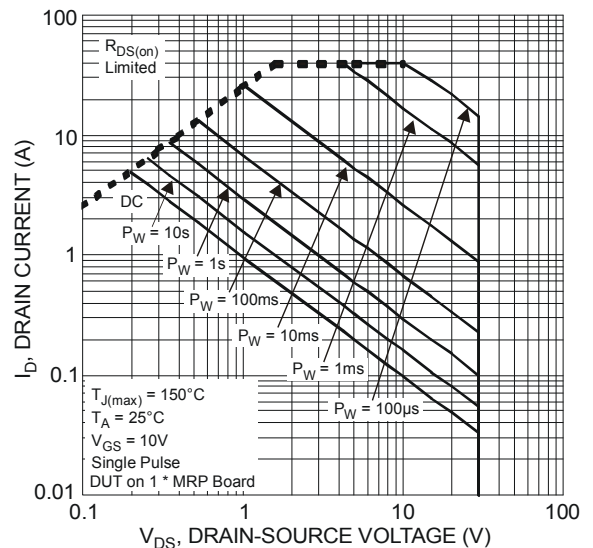


Figure 12 SOA, Safe Operation Area

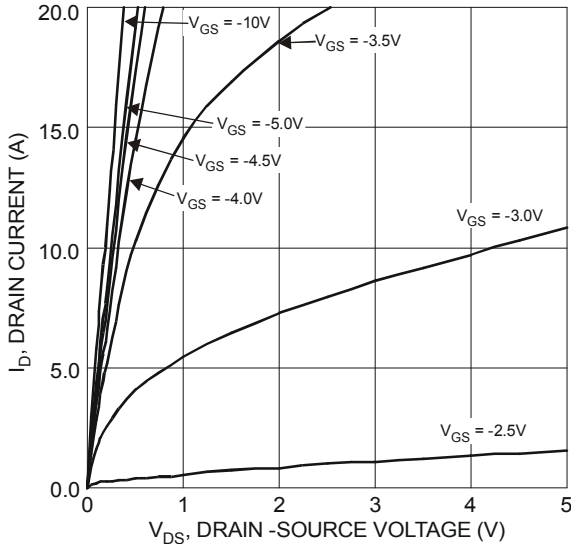


Figure 13 Typical Output Characteristics

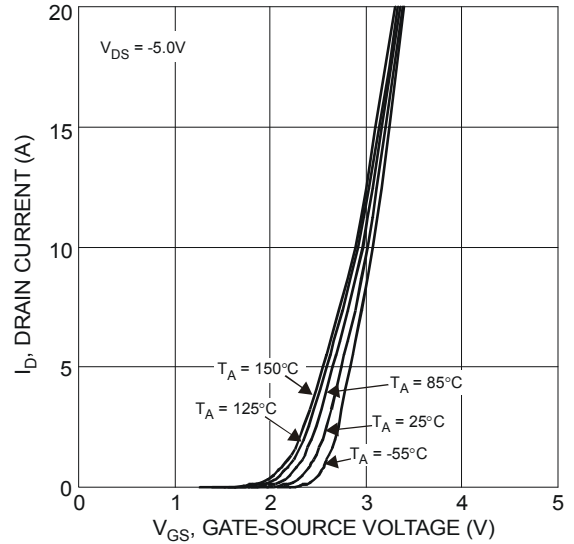


Figure 14 Typical Transfer Characteristics

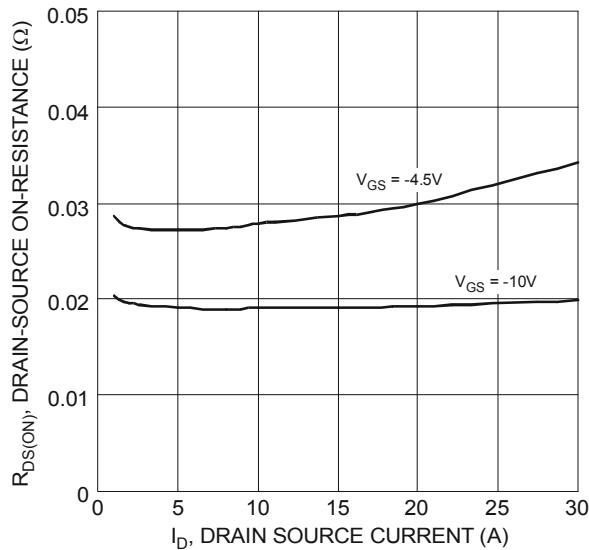


Figure 15 Typical On-Resistance vs. Drain Current and Gate Voltage

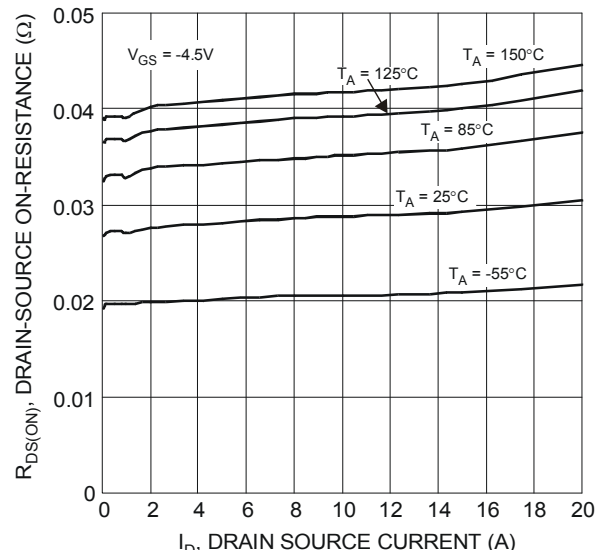


Figure 16 Typical On-Resistance vs. Drain Current and Temperature

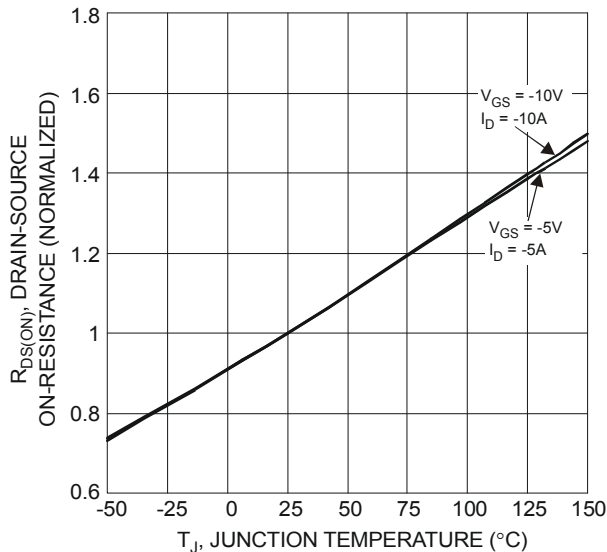


Figure 17 On-Resistance Variation with Temperature

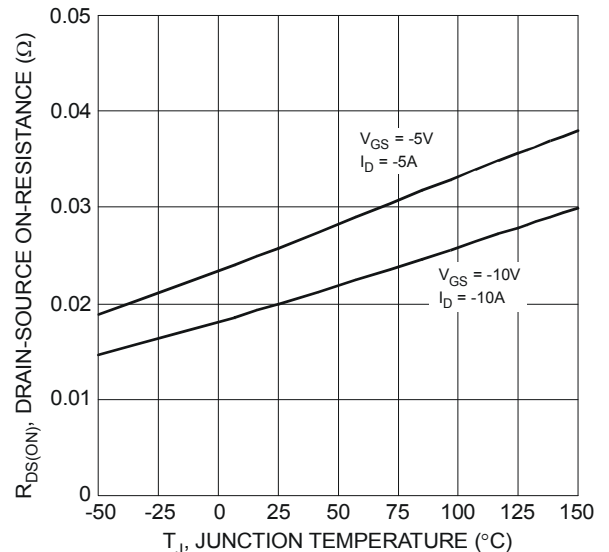


Figure 18 On-Resistance Variation with Temperature

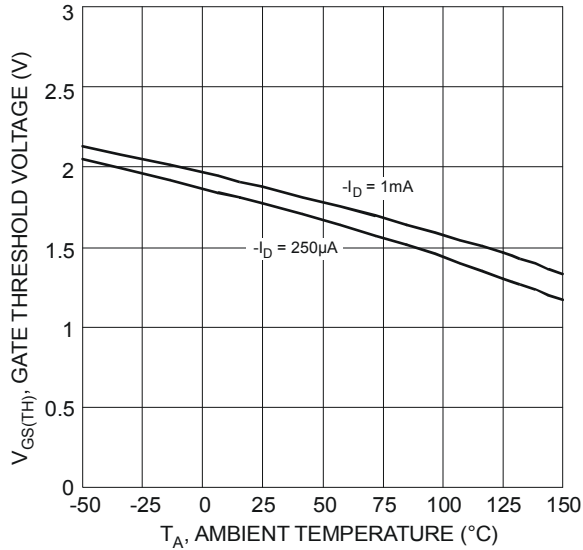


Figure 19 Gate Threshold Variation vs. Ambient Temperature

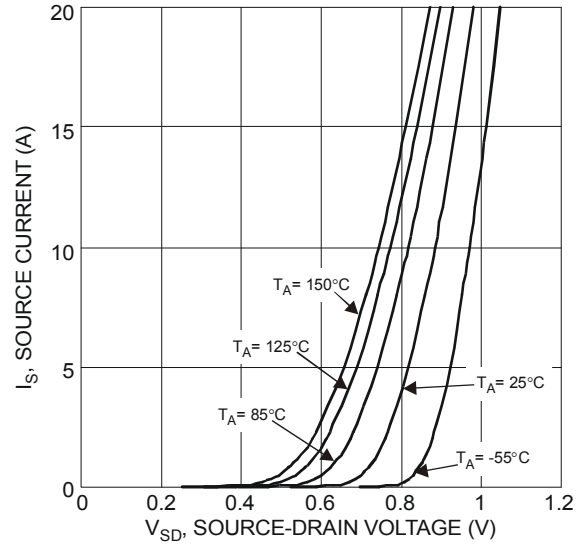


Figure 20 Diode Forward Voltage vs. Current

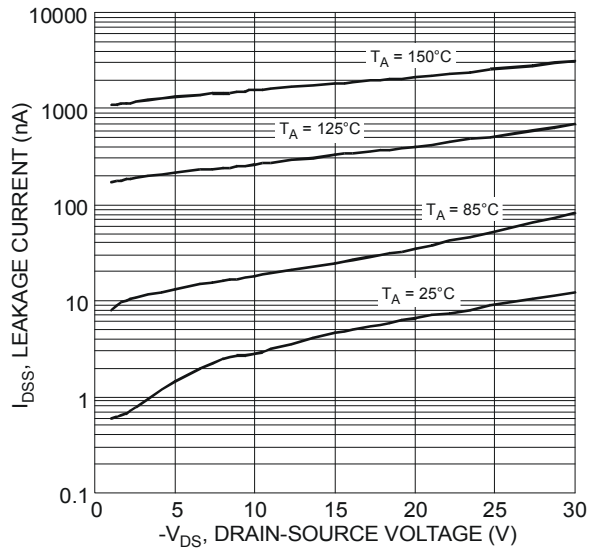


Figure 21 Typical Drain-Source Leakage Current vs. Voltage

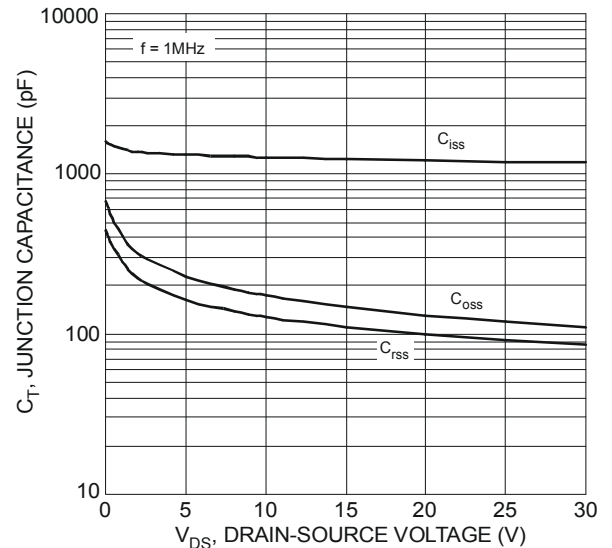


Figure 22 Typical Junction Capacitance

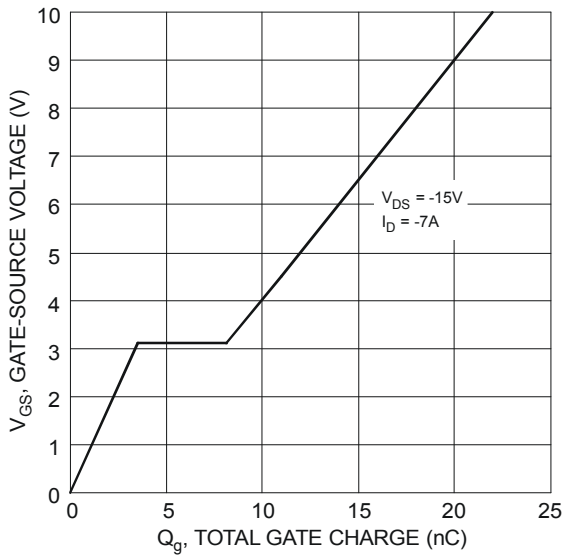


Figure 23 Gate-Charge Characteristics

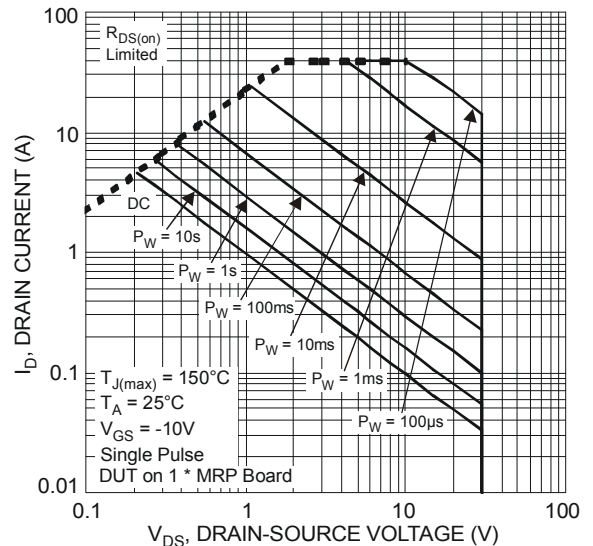
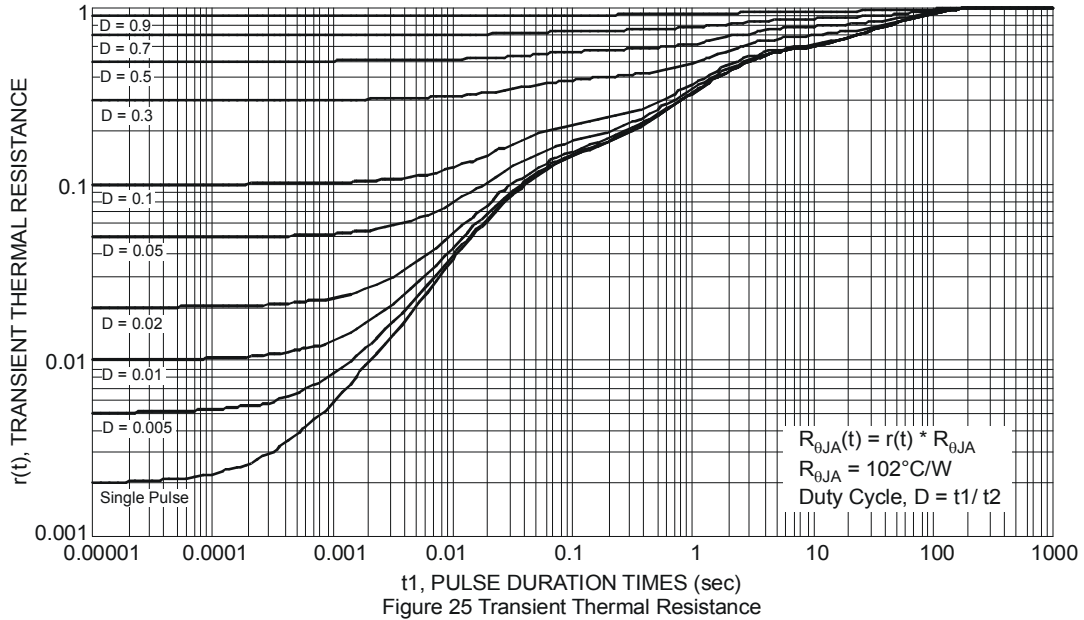
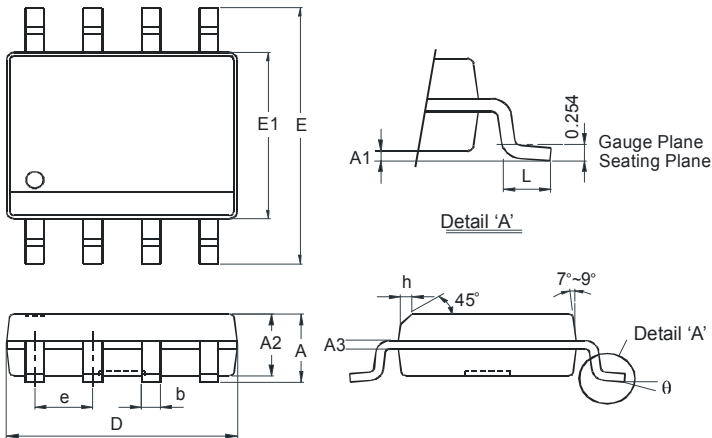


Figure 24 SOA, Safe Operation Area



Package Outline Dimensions

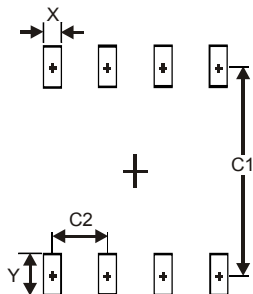
Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for latest version.



| SO-8 | | |
|----------------------|----------|------|
| Dim | Min | Max |
| A | - | 1.75 |
| A1 | 0.10 | 0.20 |
| A2 | 1.30 | 1.50 |
| A3 | 0.15 | 0.25 |
| b | 0.3 | 0.5 |
| D | 4.85 | 4.95 |
| E | 5.90 | 6.10 |
| E1 | 3.85 | 3.95 |
| e | 1.27 Typ | |
| h | - | 0.35 |
| L | 0.62 | 0.82 |
| θ | 0° | 8° |
| All Dimensions in mm | | |

Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| X | 0.60 |
| Y | 1.55 |
| C1 | 5.4 |
| C2 | 1.27 |

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